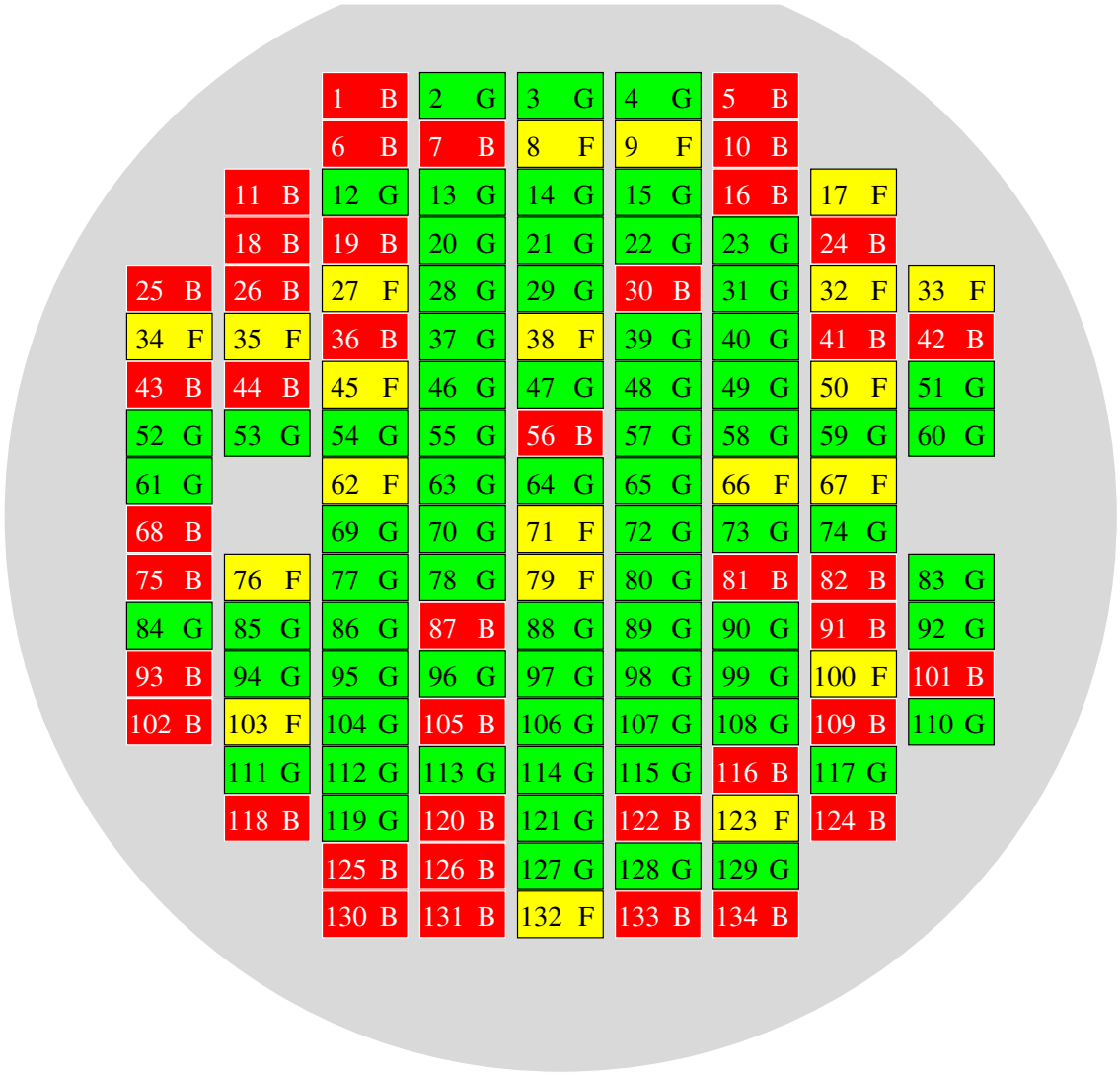
Die quality map for wafer 198 s/n: 21316-14-15

Date: 09/27/99



# B	Bad die
# F	Fair die
# G	Good die
# N	No info
# *	Manually tagged